

# GR1500JT17-263

# Normally – OFF Silicon Carbide Junction Transistor

V <sub>DS</sub>	=	1700 V
R <sub>DS(ON)</sub>	=	1.5 Ω
I <sub>D (@ 25°C)</sub>	=	2 A
h <sub>FE (@ 25°C)</sub>	=	100

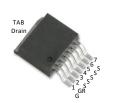
#### **Features**

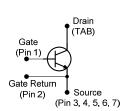
- 175 °C Maximum Operating Temperature
- · Gate Oxide Free SiC Switch
- Exceptional Safe Operating Area
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low Output Capacitance
- Positive Temperature Coefficient of RDS,ON
- Suitable for Connecting an Anti-parallel Diode

#### **Advantages**

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal Distortion
- · High Amplifier Bandwidth

#### **Package**







7L D2PAK (TO-263-7L)

Please note: The Source and Gate Return pins are not exchangeable. Their exchange might lead to malfunction.

#### **Applications**

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

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#### **Section I: Absolute Maximum Ratings**

Parameter	Symbol	Conditions	Value	Unit	Notes
Drain – Source Voltage	$V_{DS}$	V <sub>GS</sub> = 0 V	1700	V	
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> = 25°C	2	Α	
Continuous Gate Current	$I_{G}$		0.1	Α	
Turn-Off Safe Operating Area	RBSOA	T <sub>VJ</sub> = 175 <sup>°</sup> C, Clamped Inductive Load	$I_{D,max} = 2$ $\bigcirc V_{DS} \le V_{DSmax}$	Α	Fig. 9
Short Circuit Safe Operating Area	SCSOA	$T_{VJ}$ = 175°C, $I_G$ = 0.2 A, $V_{DS}$ = 1200 V, Non Repetitive	> 20	μs	
Reverse Gate – Source Voltage	$V_{SG}$		30	V	
Reverse Drain – Source Voltage	$V_{\text{SD}}$		25	V	
Storage Temperature	T <sub>stg</sub>		-55 to 175	°C	





# **Section II: Static Electrical Characteristics**

D	Orandel Orandellana	Value					
Parameter	Symbol	Conditions	Min.	Typical	Max.	Unit	Notes
A: On State							
Orain – Source On Resistance	R <sub>DS(ON)</sub>	I <sub>D</sub> = 1 A, T <sub>j</sub> = 25 °C		1.5		Ω	
Gate – Source Saturation Voltage		$I_D = 1 \text{ A}, I_D/I_G = 40, T_j = 25 \text{ °C}$		3.45	V Fig	Fig. 4	
Sale – Source Saluration Voltage	$V_{GS,SAT}$	$I_D = 1 \text{ A}, I_D/I_G = 30, T_j = 175 °C$		3.22		V	Fig. 4
DC Current Gain	$h_{FE}$	$V_{DS} = 5 \text{ V}, I_{D} = 1 \text{ A}, T_{j} = 25 ^{\circ}\text{C}$		100		_	Fig. 2
B: Off State							
Orain Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 1700 V, V <sub>GS</sub> = 0 V, T <sub>j</sub> = 25 °C		0.03		μA	Fig. 5
Gate Leakage Current	$I_{SG}$	$V_{SG} = 20 \text{ V}, T_j = 25 \text{ °C}$		20		nA	_
C: Thermal							
Thermal resistance, junction - case	R <sub>thJC</sub>			4.83		°C/W	Fig. 7



# **Section III: Figures**

#### A: Static Characteristics

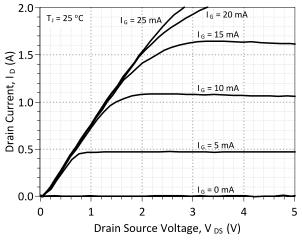


Figure 1: Typical Output Characteristics at 25 °C

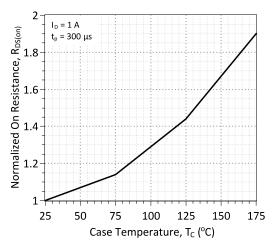


Figure 3: On-Resistance vs. Temperature

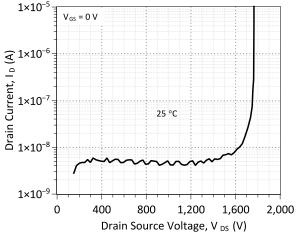


Figure 5: Typical Blocking Characteristics

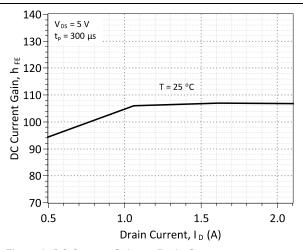


Figure 2: DC Current Gain vs. Drain Current

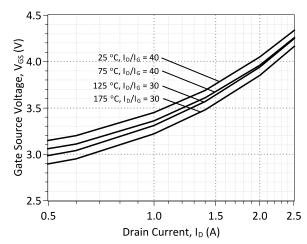


Figure 4: Typical Gate - Source Saturation Voltage

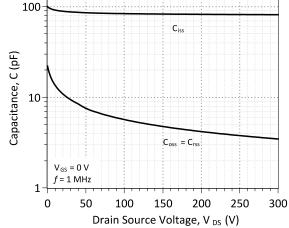


Figure 6: Input, Output, and Reverse Transfer Capacitance

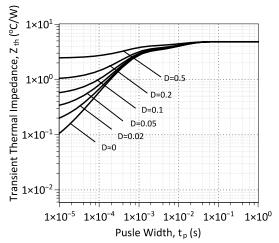


Figure 7: Transient Thermal Impedance

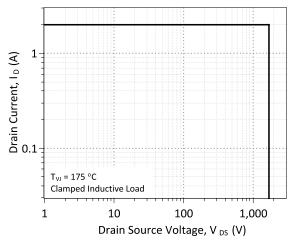


Figure 9: Turn-Off Safe Operating Area

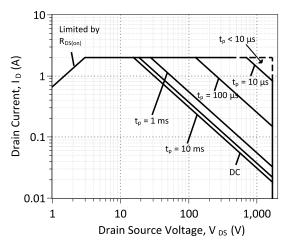


Figure 8: Forward Bias Safe Operating Area at T<sub>c</sub>= 25°C



# Section IV: Driving the GR1500JT17-263

Drive Topology	Gate Drive Power Consumption	Switching Frequency	Application Emphasis
TTL Logic	High	Low	Wide Temperature Range
Constant Current	Medium	Medium	Wide Temperature Range
High Speed – Boost Capacitor	Medium	High	Fast Switching
High Speed – Boost Inductor	Low	High	Ultra Fast Switching
Proportional	Lowest	High	Wide Drain Current Range
Pulsed Power	Medium	N/A	Pulse Power

#### Static TTL Logic Driving

The GR1500JT17-263 may be driven with direct (5 V) TTL logic and current amplification. The amplified current level of the supply must meet or exceed the steady state gate current ( $I_{G,steady}$ ) required to operate the GR1500JT17-263. Minimum  $I_{G,steady}$  is dependent on the anticipated drain current  $I_D$  through the SJT and the DC current gain  $h_{FE}$ , it may be calculated from the following equation. An accurate value of the  $h_{FE}$  may be read from Figure 2. An optional resistor  $R_G$  may be used in series with the gate pin to trim  $I_{G,steady}$ , also an optional capacitor  $C_G$  may be added in parallel with  $R_G$  to facilitate faster SJT switching if desired, further details on these options are given in the following section.

$$I_{G,steady} pprox rac{I_D}{h_{FE}(T, I_D)} * 1.5$$

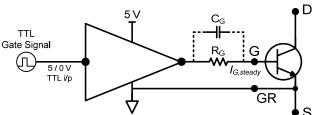


Figure 10: TTL Gate Drive Schematic

#### **High Speed Driving**

The SJT is a current controlled transistor which requires a positive gate current for turn-on and to remain in on-state. An idealized gate current waveform for ultra-fast switching of the SJT while maintaining low gate drive losses is shown in Figure 11, it features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current during on-state.

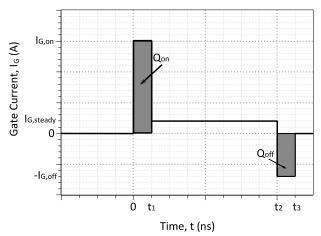


Figure 11: An idealized gate current waveform for fast switching of an SJT.

An SJT is rapidly switched from its blocking state to on-state when the necessary gate charge,  $Q_G$ , for turn-on is supplied by a burst of high gate current,  $I_{G,on}$ , until the SJT gate-source capacitance,  $C_{GS}$ , and gate-drain capacitance,  $C_{GD}$ , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$
$$Q_{on} \ge Q_{gs} + Q_{gd}$$



Ideally,  $I_{G,on}$  should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the  $I_{G,on}$  pulse is affected by the parasitic inductances,  $L_{par}$  in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path,  $L_s$ , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the  $V_{GS,sat}$  (see Figure 7) level to counter these effects.

A high negative peak current,  $-I_{G,off}$  is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. Turn off can be achieved with  $V_{GS} = 0$  V, however a negative gate voltage  $V_{GS}$  may be used in order to speed up the turn-off transition.

#### A:1: High Speed, Low Loss Drive with Boost Capacitor

The GR1500JT17-263 may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. An example of this topology is shown in Figure 12.

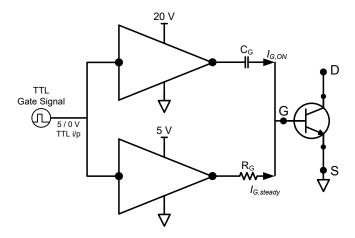


Figure 12: Simplified Boost Capacitor Drive Topology.

#### A:2: High Speed, Low Loss Drive with Boost Inductor

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GR1500JT17-263 at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses  $I_{G,on}$  and  $I_{G,off}$ . During operation, inductor L is charged to a specified  $I_{G,on}$  current value then made to discharge  $I_L$  into the SJT gate pin using logic control of  $S_1$ ,  $S_2$ ,  $S_3$ , and  $S_4$ , as shown in Figure 13. After turn on, while the device remains on the necessary steady state gate current  $I_{G,steady}$  is supplied from source  $V_{CC}$  through  $R_G$ . Please refer to the article "A current-source concept for fast and efficient driving of silicon carbide transistors" by Dr. Jacek Rąbkowski for additional information on this driving topology.<sup>3</sup>

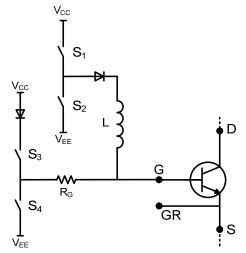


Figure 13: Simplified Inductive Pulsed Drive Topology

<sup>3 –</sup> Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/aee-2013-0026, June 2013



#### **B: Proportional Gate Current Driving**

For applications in which the GR1500JT17-263 will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate driver relies on instantaneous drain current  $I_D$  feedback to vary the steady state gate current  $I_{G,steady}$  supplied to the GR1500JT17-263

#### **Voltage Controlled Proportional Driver**

The voltage controlled proportional driver relies on a gate drive IC to detect the GR1500JT17-263 drain-source voltage  $V_{DS}$  during on-state to sense  $I_D$ . The gate drive IC will then increase or decrease  $I_{G,steady}$  in response to  $I_D$ . This allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GR1500JT17-263 are in off-state. A simplified version of this topology is shown in Figure 14, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/

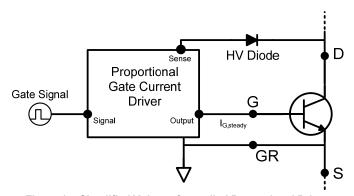


Figure 14: Simplified Voltage Controlled Proportional Driver

#### **Current Controlled Proportional Driver**

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback  $I_D$  of the GR1500JT17-263 during on-state to supply  $I_{G,steady}$  into the device gate.  $I_{G,steady}$  will then increase or decrease in response to  $I_D$  at a fixed forced current gain which is set be the turns ratio of the transformer,  $h_{force} = I_D / I_G = N_2 / N_1$ . GR1500JT17-263 is initially turned-on using a gate current pulse supplied into an RC drive circuit to allow  $I_D$  current to begin flowing. This topology allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A simplified version of this topology is shown in Figure 15, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/.

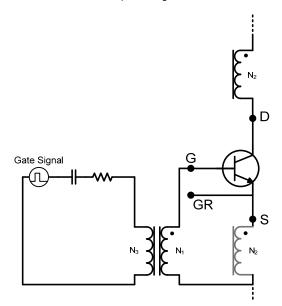


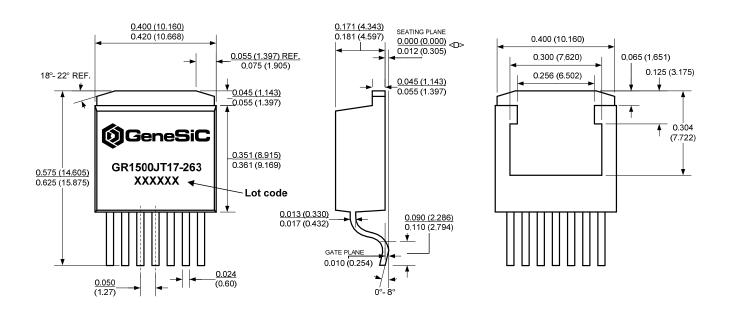
Figure 15: Simplified Current Controlled Proportional Driver



### **Section V: Package Dimensions**

#### TO-263-7

#### **PACKAGE OUTLINE**



#### NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History					
Date	Revision	Comments	Supersedes		
2016/04/04	0	Initial release			

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#### **Section VI: SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products\_sic/sjt/GR1500JT17-263\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GR1500JT17-263.

```
MODEL OF GeneSiC Semiconductor Inc.
*
                                  $
     $Revision:
                   1.0
     $Date: 04-APR-2016
                                  $
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* Models accurate up to 2 times rated drain current.
.model GR1500JT12 NPN
+ IS
           9.8338E-48
+ ISE
           1.0733E-26
+ EG
           3.23
+ BF
           110
           0.55
+ BR
           5000
+ IKF
+ NF
+ NE
           2
+ RB
           20
           0.002
+ IRB
+ RBM
           0.6
           0.003
+ RE
+ RC
           1.5
+ CJC
           25E-12
+ VJC
+ MJC
           0.5
           80E-12
+ CJE
+ VJE
           3
           0.5
+ MJE
+ XTI
           3
+ XTB
           -1.5
           6.5E-3
+ TRC1
+ VCEO
           1700
           GeneSiC_Semiconductor
+ MFG
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\* End of GR1500JT12 SPICE Model